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# Sticking and Re-erosion of C<sub>x</sub>H<sub>y</sub> Molecules

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#### Introduction



- Chemical sputtering of carbon by hydrogen produces volatile hydrocarbon species (C<sub>x</sub>H<sub>y</sub>)
- These  $C_xH_y$  species are transported through the plasma boundary layer
- Neutral C<sub>x</sub>H<sub>y</sub> species are not confined by the magnetic field and can be transported to remote areas
- Redeposition of hydrocarbon films due to long range transport of  $C_xH_y$  species with low surface loss probability
- Investigation of neutral, low-energy radicals in laboratory plasmas (next slide)
- Ionisation in the boundary layer produces energetic C<sub>x</sub>H<sub>y</sub> species. Little is known about their interaction with the surface (reflection and sticking data)
- Important input data for modelling of transport in the boundary plasma
- → Experimental and theoretical attempt to determine reflection and sticking coefficients of different C<sub>x</sub>H<sub>y</sub> species
- → MD results

#### Sticking of thermal neutrals

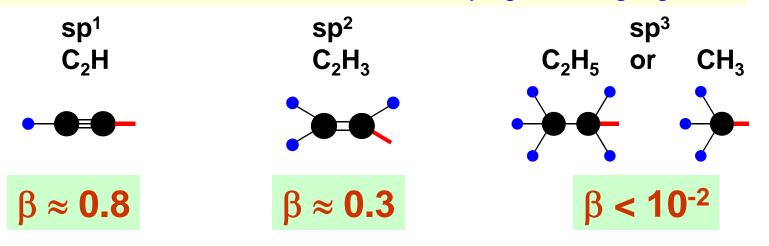


#### **Experiment:**

determination of the surface loss probability  $\beta$  of different hydrocarbon radicals in low-temperature plasmas using cavity probes **Result:** 

- $\rightarrow$  3 different  $\beta$  values are necessary and sufficient
- ➔ 3 different types of growth precursors

interpretation: β depends mainly on the hybridisation state of the carbon atom carrying the dangling bond



C. Hopf, T. Schwarz-Selinger, W. Jacob, and A. von Keudell: "Surface Loss Probabilities of Hydrocarbon Radicals on Amorphous Hydrogenated Carbon Film Surfaces", Journal of Applied Physics 87, 2719–2725 (2000).

#### **Theoretical description**



#### **TRIM (binary collision approximation):**

- applicable at high energies ( $E_{ion} > 50 \text{ eV}$ )
- fast
- can not treat molecular effects

#### Molecular dynamics (solution of equation of motion):

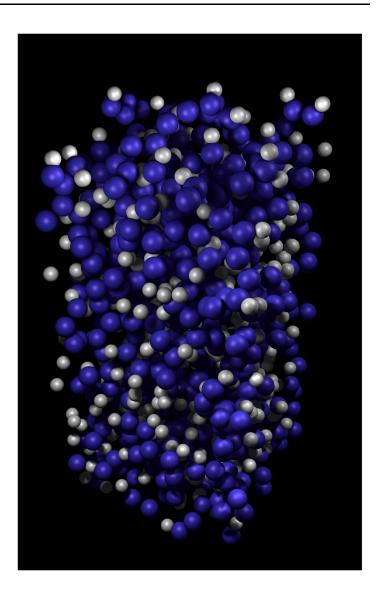
- applicable at low energies ( $E_{ion} < 100 \text{ eV}$ )
- slow (computation time intensive)
- can treat molecular effects
- But quality of results depends on quality of used interaction potential
- Experimental verification of (some) results highly desirable

## MD sample (amorphous hydrogenated carbon, a-C:H)

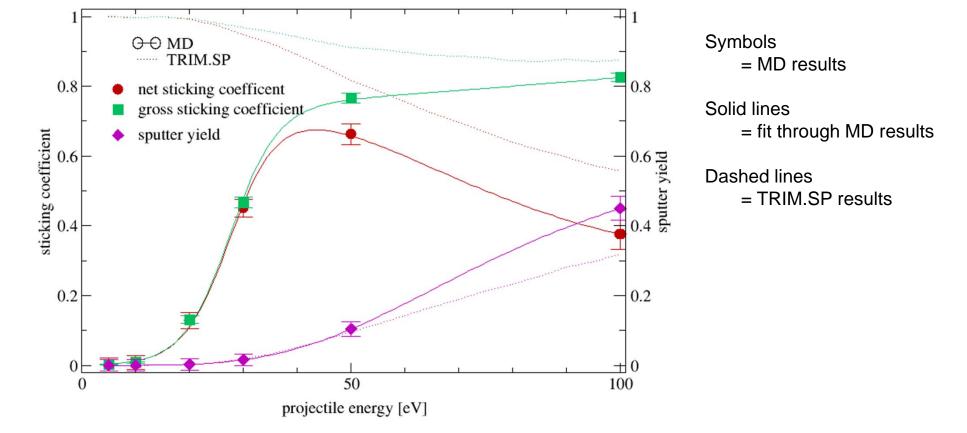


- 986 Atoms
  - 592 Carbon
  - 384 Hydrogen / Deuterium
- 14 Å x 14 Å x 30 Å
- Production:
  - Random placement of atoms
  - multiple annealing cycles

P. N. Maya, U. von Toussaint, and C. Hopf: Synergistic erosion process of hydrocarbon films: A molecular dynamics study. *New J. Phys.,* **10**, 023002 (15pp), 2008.



#### Sticking of CH<sub>4</sub>: TRIM vs. MD

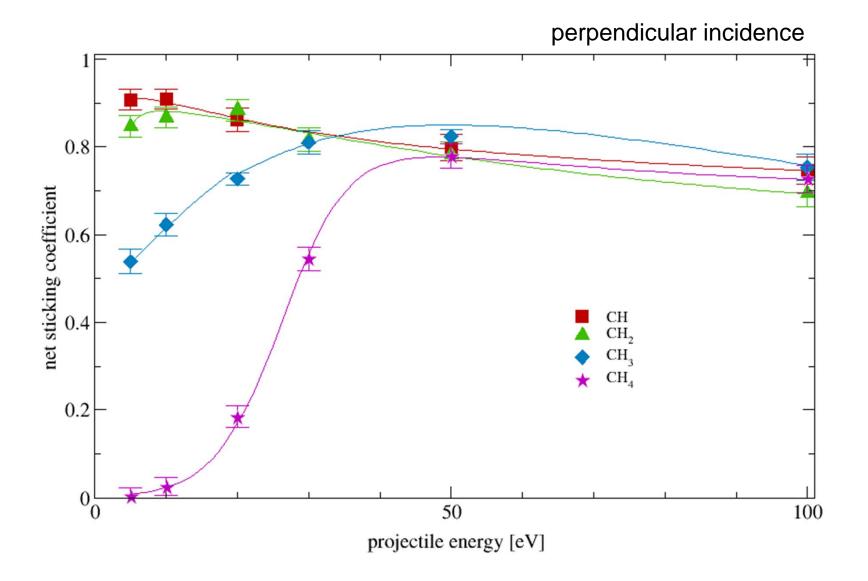


Threshold energy for sticking TRIM results comparable at high energies TRIM yields wrong trend at low energies



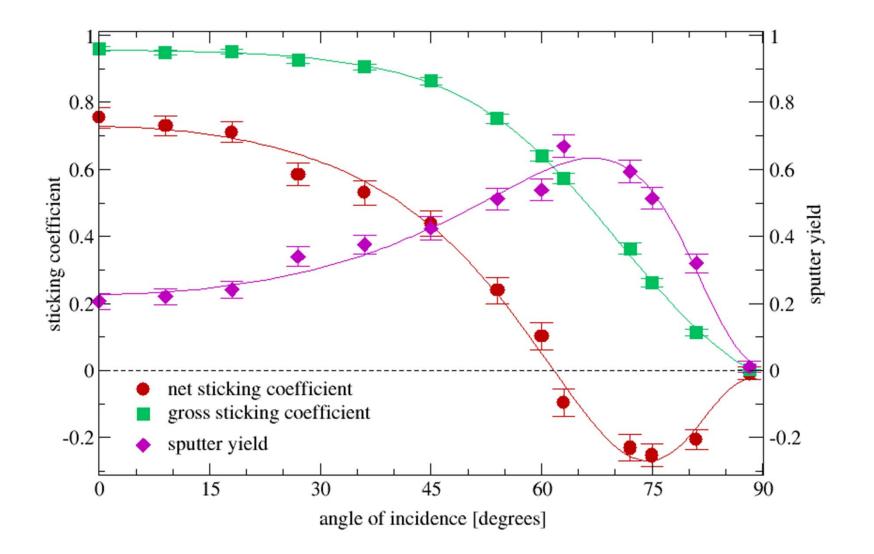
### Sticking of different CH<sub>y</sub> species: Energy dependence





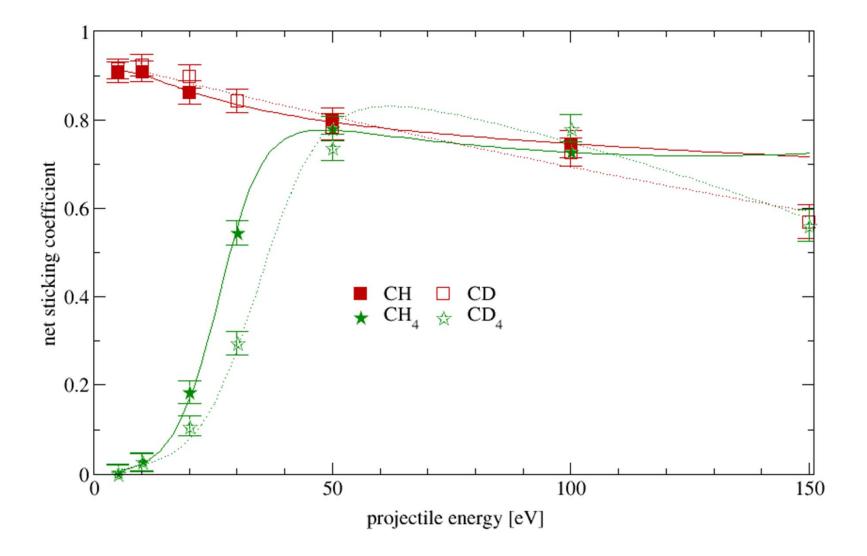
### Sticking of CH<sub>3</sub> (100 eV): Angle dependence





# Sticking of different CH<sub>y</sub> species: Isotope effect





#### Fit formulae



Angle dependence

$$Y(E_0, \theta_0) = Y(E_0, 0) \left\{ \cos \left[ \left( \frac{\theta_0}{\theta_0^*} \frac{\pi}{2} \right)^c \right] \right\}^{c} \times \exp \left[ b \left\{ 1 - 1 / \cos \left[ \left( \frac{\theta_0}{\theta_0^*} \frac{\pi}{2} \right)^c \right] \right\} \right)$$

$$\theta_0^* = \pi - \arccos \sqrt{\frac{1}{1 + E_0 E_{\rm sp}}}.$$

K. Tichmann, U. von Toussaint, T. Schwarz-Selinger, and W. Jacob: "Determination of the Sticking Probability of Hydrocarbons on an Amorphous Hydrocarbon Surface" Physica Scripta T138, 014015 (4pp) (2009).

K. Tichmann, U. von Toussaint, T. Schwarz-Selinger, and W. Jacob: "Measurement and Modeling of Reflection and Sticking Probabilities of Energetic Hydrocarbon Species" Journal of Nuclear Materials, accepted (2010) (PSI-Proceedings).

	$E_0[eV]$	Y(0)	$E_{\rm sp}[{\rm eV}]$	f	b	С
CH <sub>4</sub>	20	0.00152	2.8	20.1	14.8	0.492
	30	0.0306	2.8	-2.76	-0.447	1.13
	50	0.0799	2.8	3.19	1.84	1.23
	100	0.213	2.8	6.36	3.46	0.914
CH <sub>3</sub>	20	0.0118	2.8	8.7	5.72	0.957
	30	0.0433	2.8	3.71	2.34	1.07
	50	0.106	2.8	3.09	1.44	1.19
	100	0.227	2.8	5.1	2.51	0.966
CH <sub>2</sub>	20	0.0316	2.8	7.08	4.4	1.1
	30	0.0879	2.8	1.66	0.852	1.35
	50	0.145	2.8	3.46	1.63	1.13
	100	0.264	2.8	4.9	2.37	0.96
CH	10	0.0143	2.8	7.36	4.71	1.52
	20	0.0566	2.8	3.91	2.22	1.17
	50	0.129	2.8	5.23	2.53	0.966
	100	0.221	2.8	6.5	3.19	0.841
С	10	0.0105	2.8	7.75	4.4	2.17
	20	0.0501	2.8	2.96	1.62	1.28
	50	0.139	2.8	3.99	1.76	1.08
	100	0.236	2.8	5.9	2.76	0.886



- Sticking and reflection of C<sub>x</sub>H<sub>y</sub> was simulated by MD
- Energy dependence
- Angle dependence
- Species dependence
- Isotope effect
- Simulated data were fitted by empirical fit functions
- Complete set of data is available



# END